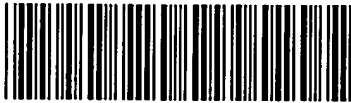


Search Notes

Application/Control No.

10/750,845

Examiner

John S. Chu

Applicant(s)/Patent under
Reexamination

KANG ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	165	9/2005	JY
430	166		
430	189		
430	191		
430	192		
430	193		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH UPDATED	9/2005	JY